

Test Report

No. : CE/2007/17649

Date : 2007/02/05

Page : 1 of 3

ELAN MICROELECTRONICS CORPORATION
NO. 12, INNOVATION 1 ST RD., SCIENCE-BASED INDUSTRIAL
PARK, HSINCHU CITY, TAIWAN 308, R. O. C.



The following sample(s) was/were submitted and identified by/on behalf of the client as :

Sample Description : WAFER (OR CHIP FORM)
Style/Item No. : GREEN PRODUCT
Buyer/Order No. : ELAN
Sample Receiving Date : 2007/01/29
Testing Period : 2007/01/29 TO 2007/02/05

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Test Requested : In accordance with the RoHS Directive 2002/95/EC, and its amendment directives.

Test Method : With reference to IEC 62321, Ed.1 111/54/CDV
Procedures for the Determination of Levels of Regulated
Substances in Electrotechnical Products.
(1) Determination of Cadmium by ICP-AES.
(2) Determination of Lead by ICP-AES.
(3) Determination of Mercury by ICP-AES.
(4) Determination of Hexavalent Chromium for non-metallic
samples by UV/Vis Spectrometry.
(5) Determination of PBB and PBDE by GC/MS.

Test Result(s) : Please refer to next page(s).


Daniel Yeh, M.R. / Operation Manager
Signed for and on behalf of
SGS TAIWAN LTD.

Test Report

No. : CE/2007/17649

Date : 2007/02/05

Page : 2 of 3

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Test results by chemical method (Unit: mg/kg)

Test Item (s):	Method (Refer to)	Result	MDL
		No.1	
Cadmium (Cd)	(1)	n.d.	2
Lead (Pb)	(2)	n.d.	2
Mercury (Hg)	(3)	n.d.	2
Hexavalent Chromium Cr(VI) by alkaline extraction	(4)	n.d.	2
Sum of PBBs	(5)	n.d.	-
Monobromobiphenyl		n.d.	5
Dibromobiphenyl		n.d.	5
Tribromobiphenyl		n.d.	5
Tetrabromobiphenyl		n.d.	5
Pentabromobiphenyl		n.d.	5
Hexabromobiphenyl		n.d.	5
Heptabromobiphenyl		n.d.	5
Octabromobiphenyl		n.d.	5
Nonabromobiphenyl		n.d.	5
Decabromobiphenyl		n.d.	5
Sum of PBDEs (Mono to Nona) (Note 4)		n.d.	-
Monobromobiphenyl ether		n.d.	5
Dibromobiphenyl ether		n.d.	5
Tribromobiphenyl ether		n.d.	5
Tetrabromobiphenyl ether		n.d.	5
Pentabromobiphenyl ether		n.d.	5
Hexabromobiphenyl ether		n.d.	5
Heptabromobiphenyl ether		n.d.	5
Octabromobiphenyl ether		n.d.	5
Nonabromobiphenyl ether	n.d.	5	
Decabromobiphenyl ether	n.d.	5	
Sum of PBDEs (Mono to Deca)	n.d.	-	

TEST PART DESCRIPTION:

NO.1 : WAFER

Note : 1. mg/kg = ppm

2. n.d. = Not Detected

3. MDL = Method Detection Limit

4. Sum of Mono to NonaBDE & according to 2005/717/EC DecaBDE is exempt.

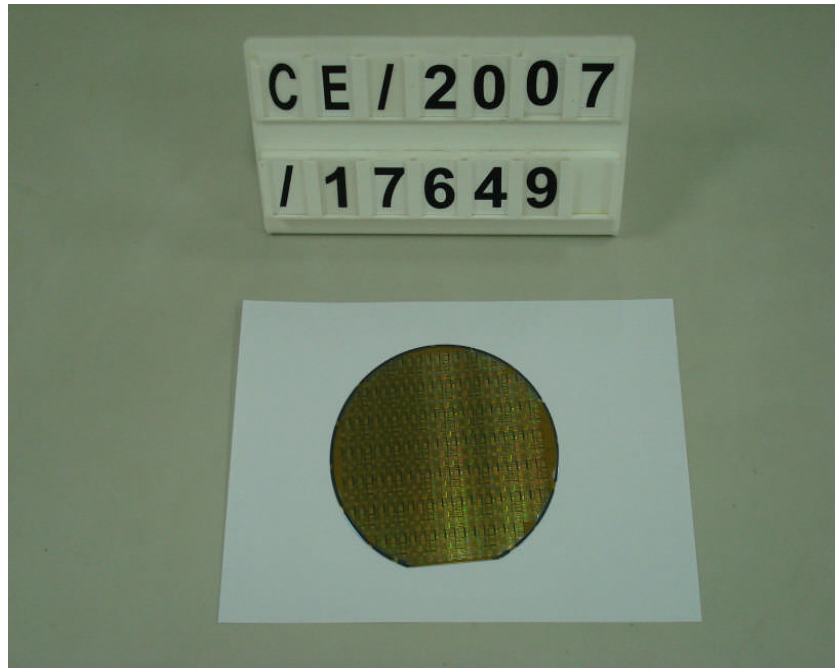
5. "-" = Not Regulated

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No. : CE/2007/17649 Date : 2007/02/05

Page : 3 of 3

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** End of Report **